BU4530AW

GENERAL DESCRIPTION

Enhanced performance, new generation, high-voltage, high-speed switching npn transistor in a plastic envelope intended for use in horizontal deflection circuits of colour television receivers and p.c monitors. Features exceptional tolerance to base drive and collector current load variations resulting in a very low worst case dissipation.

QUICK REFERENCE DATA

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
V _{CESM}	Collector-emitter voltage peak value	$V_{BE} = 0$	-	1500	V
V _{CEO}	Collector-emitter voltage (open base)		-	800	V
Ic	Collector current (DC)		-	16	Α
1 1	Collector current peak value		-	40	А
P _{tot}	Total power dissipation	T _{mb} ≤ 25 °C	-	125	W
P _{tot} V _{CEsat}	Collector-emitter saturation voltage	$I_{\rm C} = 10 \text{ A}; I_{\rm B} = 2.22 \text{ A}$	-	3.0	V
I _{Csat}	Collector saturation current	f = 32 kHz	9	-	Α
obut		f = 90 kHz	8	-	Α
t _f	Fall time.	I _{Csat} = 9.0 A; f = 32 kHz	0.20	0.26	μs
		$I_{Csat}^{odd} = 8.0 \text{ A}; \text{ f} = 90 \text{ kHz}$	0.12	-	μs

PINNING - SOT429

base

collector

emitter

collector

DESCRIPTION

PIN

1

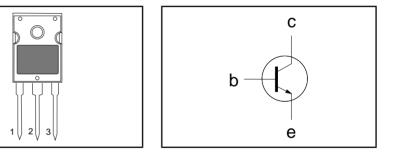
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PIN CONFIGURATION

SYMBOL



LIMITING VALUES

Limiting values in accordance with the Absolute Maximum Rating System (IEC 134)

SYMBOL	PARAMETER	CONDITIONS	MIN.	MAX.	UNIT
V _{CESM}	Collector-emitter voltage peak value	$V_{BE} = 0 V$	-	1500	V
VCEO	Collector-emitter voltage (open base)		-	800	V
I _C	Collector current (DC)		-	16	А
I _{CM}	Collector current peak value		-	40	А
I _B	Base current (DC)		-	10	А
I _{BM}	Base current peak value		-	15	А
I _{BM} P _{tot}	Total power dissipation	$T_{mb} \leq 25 \degree C$	-	125	W
T _{stq}	Storage temperature		-55	150	°C
T _j	Junction temperature		-	150	°C

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THERMAL RESISTANCES

SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
R _{th j-mb}	Junction to mounting base	-	-	1.0	K/W
R _{th j-a}	Junction to ambient	in free air	35	-	K/W

STATIC CHARACTERISTICS

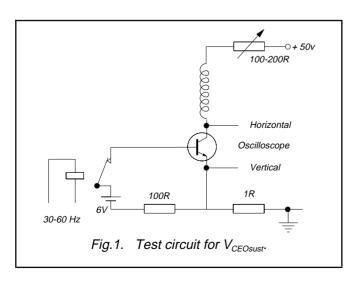
 $T_{mb} = 25$ °C unless otherwise specified

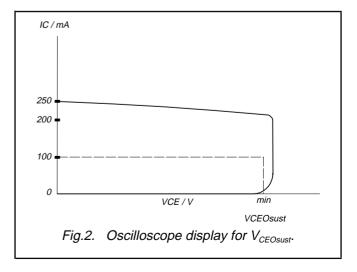
SYMBOL	PARAMETER	CONDITIONS	MIN.	TYP.	MAX.	UNIT
I _{CES}	Collector cut-off current ¹	$V_{BE} = 0 V; V_{CE} = V_{CESMmax}$	-	-	1.0	mA
I _{CES}		$V_{BE} = 0 V; V_{CE} = V_{CESMmax}$ $V_{BE} = 0 V; V_{CE} = V_{CESMmax};$ $T_i = 125 °C$	-	-	2.0	mA
BV _{EBO}	Base-emitter breakdown voltage	$I_{B}^{J} = 1 \text{ mA}$	7.5	12.8	-	V
V _{CEOsust}	Collector-emitter breakdown voltage	I _B = 0 A;I _C = 100 mA; L = 25 mH	800			V
V _{CEsat}	Collector-emitter saturation voltage	I _C = 10 A; I _B = 2.22 A	-	-	3.0	V
V _{BEsat}	Base-emitter saturation voltage	$I_{c} = 10 \text{ A}; I_{B} = 2.22 \text{ A}$	0.83	0.92	1.01	V
h _{FE}	DC current gain	$I_{\rm C} = 1 \text{ A}; V_{\rm CE} = 5 \text{ V}$	-	12	-	
h _{FE}		$I_{C} = 10 \text{ Å}; V_{CE} = 5 \text{ V}$	4.8	6.6	8.5	

DYNAMIC CHARACTERISTICS

 T_{mb} = 25 °C unless otherwise specified

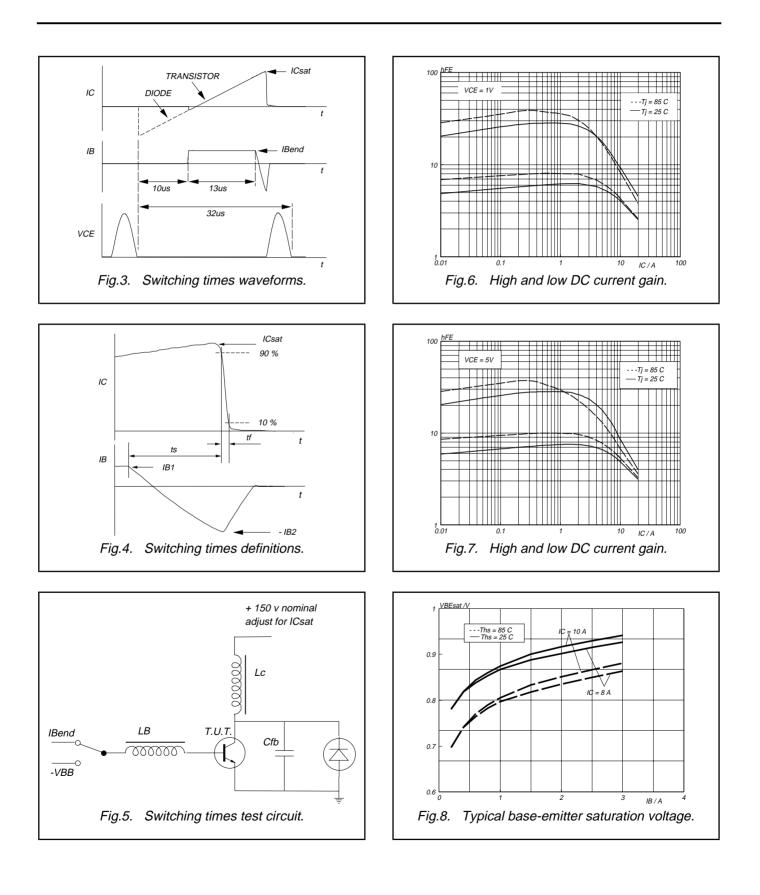
SYMBOL	PARAMETER	CONDITIONS	TYP.	MAX.	UNIT
t _s t _f	Switching times (32 kHz line deflection dynamic test circuit). Turn-off storage time Turn-off fall time	I _{Csat} = 9.0 A; I _{B1} = 1.8 A; (I _{B2} = -4.5 A)	3.0 0.20	4.0 0.26	μs μs
t _s t _f	Switching times (90 kHz line deflection dynamic test circuit). Turn-off storage time Turn-off fall time	$I_{Csat} = 8 \text{ A}; I_{B1} = 1.6 \text{ A}; (I_{B2} = -4.0 \text{ A})$	2 0.12	-	μs μs



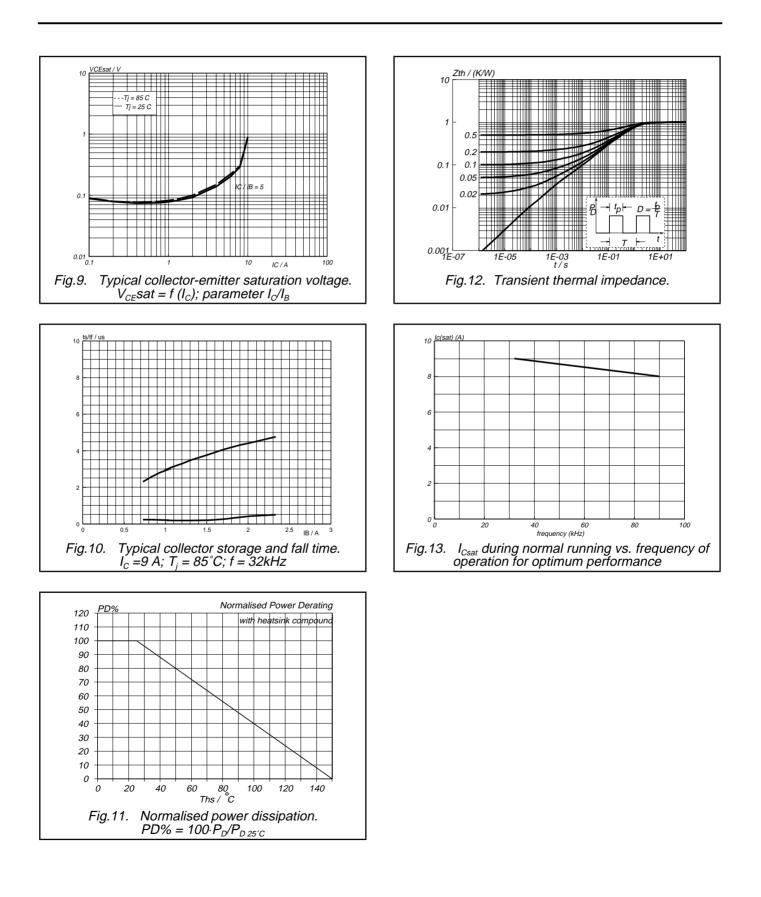


¹ Measured with half sine-wave voltage (curve tracer).

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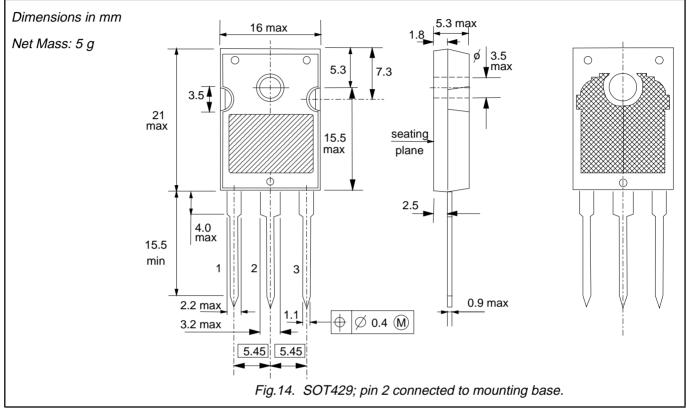


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MECHANICAL DATA



Notes

Refer to mounting instructions for SOT429 envelope.
Epoxy meets UL94 V0 at 1/8".

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DEFINITIONS

Data sheet status				
Objective specification This data sheet contains target or goal specifications for product development.				
Preliminary specification	This data sheet contains preliminary data; supplementary data may be published later.			
Product specification	This data sheet contains final product specifications.			
Limiting values				
or more of the limiting val operation of the device at	in accordance with the Absolute Maximum Rating System (IEC 134). Stress above one ues may cause permanent damage to the device. These are stress ratings only and these or at any other conditions above those given in the Characteristics sections of plied. Exposure to limiting values for extended periods may affect device reliability.			
Application information				
Where application inform	ation is given, it is advisory and does not form part of the specification.			
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